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Rambus™ XDR™ CLOCK GENERATOR

FEATURES

- High-Speed Clock Support: 300-MHz-667-MHz Clock Source for XDR Memory Subsystems and Redwood Logic Interface
- Quad (Open-Drain) Differential Output Drivers
- Spread-Spectrum Compatible Clock Input Can Be Distributed to Minimize EMI
- Differential or Single-Ended Reference Clock Input of 100 MHz or 133 MHz
- Serial Interface Features: Programmable Frequency Multiplier, Select Any One to Four Outputs and Mode of Operation
- Supports Frequency Multiplication Factors of: $\times 3, \times 4, \times 5, \times 6, \times 8, \times 9/2, \times 15/2, \times 15/4$
- All PLL Loop Filter Components Are Integrated
- Low |Cycle-to-Cycle| of 1–6 Cycle Jitter:

40 ps: 300–635 MHz

- 30 ps: 636-667 MHz

- PLLs Are Powered Down if No Valid REF Clock (<10 MHz) Is Detected or VDD Is Below 1 6 V
- Operates From Single 2.5-V Supply (±0.125 V)
- Packaged in TSSOP-28
- Commercial Temperature Range 0°C to 70°C

APPLICATIONS

 XDR Memory Subsystem and Redwood Logic Interface

DESCRIPTION

The CDCD5704 clock generator provides the necessary clock signals to support an XDR memory subsystem and Redwood logic interface using a reference clock input with or without spread-spectrum modulation. Contained in a 28-pin TSSOP package that includes four differential clock outputs, the CDCD5704 provides an off-the-shelf solution for a broad range of high-performance interface applications.

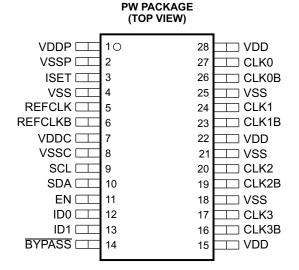
The block diagram shows the major components of the CDCD5704, which include a phase-locked loop, a bypass multiplexer, and four differential output buffers (CLK0 to CLK3). All four outputs can be disabled by a logical low at the input of the EN pin. An output is enabled when EN is high and a value of 1 is in its serial interface register (RegA–RegD).

The PLL receives a reference clock input signal, REFCLK, and outputs a clock signal at a frequency equal to the input frequency times the multiplication factor. The PLL output clock signal is fed to the differential output buffers to drive the enabled clocks. Disabled outputs are set to high impedance.

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The bypass mode routes the input clock REFCLK to the differential output buffers, bypassing the PLL.

To ensure that the CDCD5704 clock generator always performs correctly, the device switches off the PLL and the outputs are in the high-impedance state, once the clock input is below 10 MHz. If the supply voltage VDD is less than V_{PUC} , all logic gates are reset, the PLL is powered down, and the outputs are in the high-impedance state. Therefore, the device only starts its operation if these minimum requirements are met.

Because the CDCD5704 is based on PLL circuitry, it requires a stabilization time to achieve phase-lock of the PLL. With use of an external reference clock, this signal must be fixed-frequency and fixed-phase prior to the start of stabilization time.

The device operates from a single 2.5-V supply voltage. The CDCD5704 device is characterized for operation from 0° C to 70° C.

FUNCTIONAL BLOCK DIAGRAM

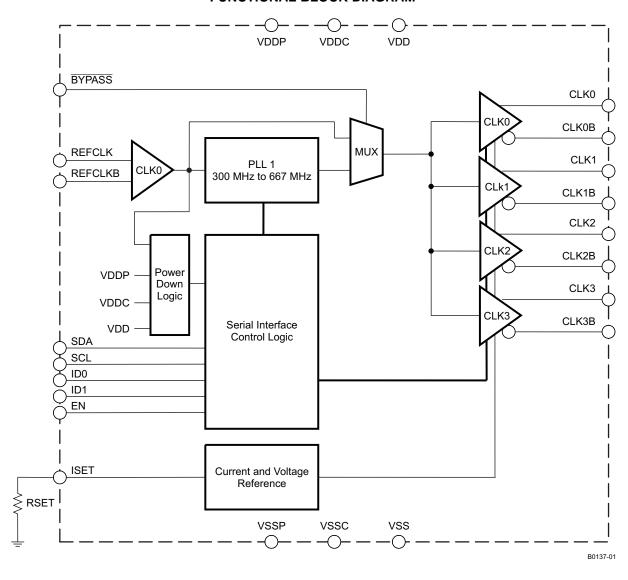




Table 1. TERMINAL FUNCTIONS

TER	RMINAL	TVDE	DECORPORTION			
NAME	NO.	TYPE	DESCRIPTION			
BYPASS	14	Input	If 0, the PLL is bypassed and the PLL is switched off.			
CLK0	27	Output	Output for Clock0			
CLK0B	26	Output	Complementary output for Clock0			
CLK1	24	Output	Output for Clock1			
CLK1B	23	Output	Complementary output for Clock1			
CLK2	20	Output	Output for Clock2			
CLK2B	19	Output	Complementary output for Clock2			
CLK3	17	Output	Output for Clock3			
CLK3B	16	Output	Complementary output for Clock3			
EN	11	Input	Output enable; if 0, all outputs are disabled.			
ID0	12	Input	Device ID, bit 0			
ID1	13	Input	Device ID, bit 1			
ISET	3	Output	Set clock driver current with external resistor			
REFCLK	5	Input	Reference clock input			
REFCLKB	6	Input	Complementary reference clock input			
SCL	9	Input	Serial interface clock, 3.3-V compatible			
SDA	10	Input	Serial interface data, 3.3-V compatible			
VDD	15, 22, 28	Power	2.5-V power supply for outputs			
VDDC	7	Power	2.5-V power supply for core			
VDDP	1	Power	2.5-V power supply for PLL			
VSS	4, 18, 21, 25	Ground	Ground			
VSSC	8	Ground	Ground for core			
VSSP	2	Ground	Ground for PLL			

SERIAL INTERFACE

The following section describes the serial interface programming. In general, the serial interface slave supports byte-write/-read and word-write/-read protocol as defined in the SMBus or I²C specification.

Serial Interface Operation Requirement

The internal timing of the serial interface logic block in the CDCD5704 requires a timing reference derived from the input clock (REFCLK). A reference clock must be present at the REFCLK pin for the serial interface to be operational.

Serial Interface Device Address

A6	A5	A4	A3	A2	A1	A0	W/R
1	1	0	1	1	ID1	ID0	0/1

The device-ID is determined by the external pins ID0 and ID1. They are part of the device 8-bit address. Therefore, four different devices (00, 01, 10, and 11) can be addressed via the same serial interface. The least significant bit of the address designates a write or read operation.

R/W Bit:

0 = write to CDCD5704 device

1 = read from CDCD5704 device



Command Code Definition

Bit	Description
C7	1 = byte-write/-read or word-write/-read operation
(C6:C0)	Byte offset for byte-write/-read or word-write/-read operation

Command Code for Byte-Write/-Read Operation	Hex Code	C7	C6	C5	C4	C3	C2	C1	C0
Byte 0	80h	1	0	0	0	0	0	0	0
Byte 1	81h	1	0	0	0	0	0	0	1
Byte 2	82h	1	0	0	0	0	0	1	0

Command Code for Word-Write/-Read Operation	Hex Code	C7	C6	C5	C4	C3	C2	C1	C0
Word 0: Byte 0 and byte 1	80h	1	0	0	0	0	0	0	0
Word 1: Byte 1 and byte 2	81h	1	0	0	0	0	0	0	1

Serial Interface Generic Programming Sequence

1	7	1	1	8	1	1
S	Slave Address	Wr	Α	Data Byte	Α	Р

S Start Condition

Sr Repeated Start Condition

Rd Read (Bit Value = 1)

Wr Write (Bit Value = 0)

A Acknowledge (ACK = 0 and NACK = 1)

P Stop Condition

PE Packet Error

Master-to-Slave Transmission

Slave-to-Master Transmission

M0053-01

Byte-Write Programming Sequence

1	7	7 1 1 8		8	1	8	1	1
S	Slave Address	Wr	Α	Command Code	Α	Data Byte	Α	Р

Byte-Read Programming Sequence

. 1	/	. 1	1	8		ı	/	. !	
S	Slave Address	Wr	Α	Command Code	Α	S	Slave Address	Rd	Α

8	1	. 1	
 Data Byte	Α	Р	



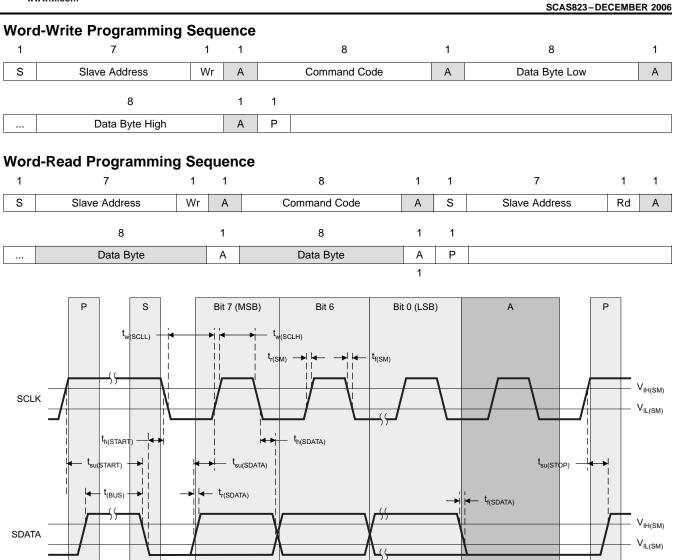


Figure 1. Timing Diagram, Serial Control Interface

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Serial Interface Configuration Command Bitmap

Byte 0

Bit	Bit Name	Description/Function	Туре	Power-Up Condition
7	RES	Reserved	R/W	0
6	MULT2	Multiplication factor, bit 2	R/W	0
5	MULT1	Multiplication factor, bit 1	R/W	0
4	MULT0	Multiplication factor, bit 0	R/W	1
3	RegA	Enable CLK0	R/W	1
2	RegB	Enable CLK1	R/W	1
1	RegC	Enable CLK2	R/W	1
0	RegD	Enable CLK3	R/W	1

Byte 1

Bit	Bit Name	Description/Function	Type	Power-Up Condition
7	RES	Reserved	R/W	0
6	RES	Reserved	R/W	0
5	RES	Reserved	R/W	0
4	RES	Reserved	R/W	0
3	RES	Reserved for vendor option	R/W	0
2	RES	Reserved for vendor option	R/W	0
1	RES	Reserved for vendor option	R/W	0
0	RegTest	Vendor test register. If high, then Vendor Test	R/W	0

Byte 2

Bit	Bit Name	Description/Function	Type	Power-Up Condition
7	REV0	Device revision, bit 4	R	0
6	REV0	Device revision, bit 3	R	0
5	REV0	Device revision, bit 2	R	0
4	REV0	Device revision, bit 1	R	0
3	REV0	Device revision, bit 0	R	0
2	VID2	Vendor ID bit 2	R	0
1	VID1	Vendor ID bit 1	R	1
0	VID0	Vendor ID bit 0	R	1



FUNCTIONAL DESCRIPTION OF THE LOGIC

PLL Multiplication Factor Selection

Mult2	Mult1	Mult0	Multiplication	Output Freq	uency (MHz)
Willitz	Wuiti	Wuito	Factor	REFCLK = 100 MHz	REFCLK = 133 MHz
0	0	0	3	300	400
0(1)	0(1)	1 (1)	4(1)	400	533
0	1	0	5	500	667
0	1	1	6	600	800 ⁽²⁾
1	0	0	8	800 ⁽²⁾	_(2)
1	0	1	9/2	450	600
1	1	0	15/2	750 ⁽²⁾	_(2)
1	1	1	15/4	375	500

⁽¹⁾ Default settings after power up

Modes of Operation

EN	BYPASS	Reg-Test	RegA	RegB	RegC	RegD	CLK0	CLK1	CLK2	CLK3
L	Х	Х	Χ	Х	Х	Х	HI-Z	HI-Z HI-Z		HI-Z
Н	Х	1	Χ	Х	Х	Х	RES	ERVED FOR	R VENDOR T	EST
Н	L	0	Χ	Х	Х	Х	REFCLK	REFCLK	REFCLK	REFCLK
Н	Н	0	0	0	0	0	HI-Z	HI-Z	HI-Z	HI-Z
Н	Н	0	1	0	0	0	PLL CLK	HI-Z	HI-Z	HI-Z
Н	Н	0	0	1	0	0	HI-Z	PLL CLK	HI-Z	HI-Z
Н	Н	0	1	1	0	0	PLL CLK	PLL CLK	HI-Z	HI-Z
Н	Н	0	0	0	1	0	HI-Z	HI-Z	PLL CLK	HI-Z
Н	Н	0	1	0	1	0	PLL CLK	HI-Z	PLL CLK	HI-Z
Н	Н	0	0	1	1	0	HI-Z	PLL CLK	PLL CLK	HI-Z
Н	Н	0	1	1	1	0	PLL CLK	PLL CLK	PLL CLK	HI-Z
Н	Н	0	0	0	0	1	HI-Z	HI-Z	HI-Z	PLL CLK
Н	Н	0	1	0	0	1	PLL CLK	HI-Z	HI-Z	PLL CLK
Н	Н	0	0	1	0	1	HI-Z	PLL CLK	HI-Z	PLL CLK
Н	Н	0	1	1	0	1	PLL CLK	PLL CLK	HI-Z	PLL CLK
Н	Н	0	0	0	1	1	HI-Z	HI-Z	PLL CLK	PLL CLK
Н	Н	0	1	0	1	1	PLL CLK	HI-Z	PLL CLK	PLL CLK
Н	Н	0	0	1	1	1	HI-Z	PLL CLK	PLL CLK	PLL CLK
Н	Н	0 ⁽¹⁾	1 ⁽¹⁾	1 ⁽¹⁾	1 ⁽¹⁾	1 ⁽¹⁾	PLL CLK	PLL CLK	PLL CLK	PLL CLK

⁽¹⁾ Default settings after power up

⁽²⁾ Output at this frequency does not conform to all the ac device characteristics in the *Device Characteristics* table, or ouput frequency is not supported.



ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted)(1)

			VALUE	UNIT
V_{DD}	Supply voltage range		-0.3 to 2.8	V
\/	Input voltage range (2)	For SCL and SDA	-0.3 to 3.6	V
VI	input voltage range (=)	For all other inputs	-0.3 to V _{DD} + 0.25	V
Vo	Output voltage range (2)		-0.5 to V _{DD} + 0.5	V
I _{IK}	Input clamp current, $(V_I < 0, V_I > V_{DD})$		±20	mA
Io	Continuous output current		±50	mA
		No airflow	94.4	
В	Thermal registeres innetion to embient (3)	Airflow 150 ft/min	82.8	K/W
$R_{\theta JA}$	Thermal resistance, junction-to-ambient (3)	Airflow 250 ft/min	79.1	r/vv
		Airflow 500 ft/min	74	
$R_{\theta JC}$	Thermal resistance, junction-to-case (3)	No airflow	31.8	K/W
$R_{\theta JB}$	Thermal resistance, junction-to-board (3)	No airflow	68.9	K/W
T_J	Maximum junction temperature		125	°C
T _{stg}	Storage temperature range		-65 to 150	°C

⁽¹⁾ Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

RECOMMENDED DC OPERATING CONDITIONS

		MIN	NOM	MAX	UNIT
V_{DDP}	Supply voltage for PLL	2.375	2.5	2.625	V
V_{DDC}	Supply voltage for core	2.375	2.5	2.625	V
V_{DD}	Supply voltage for clock buffers	2.375	2.5	2.625	V
T _A	Operating free-air temperature	0		70	°C
V _{IL,CLK}	Low-level input voltage, REFCLK/REFCLKB	-0.15		0.15	V
V _{IX,CLK}	Crossing-point voltage, input voltage threshold, REFCLK/REFCLKB	0.2		0.55	V
V _{IH,CLKD}	High-level input voltage, REFCLK/REFCLKB	0.6		0.95	V
$\Delta V_{IX,CLK}$	Difference in crossing-point voltage			0.15	V
V _{IL SE}	Low-level, single-ended input voltage, REFCLK	-0.15		$V_{th SE} - 0.3$	V
V _{th SE}	Single-ended input-voltage threshold, REFCLK (1)	0.35		0.5 V _{DD}	V
V _{IH SE}	High-level, single-ended input voltage, REFCLK	V _{th SE} + 0.3		2.625	V
V _{IL L}	Low-level input voltage, ID0, ID1, EN, BYPASS	-0.15		0.8	V
V _{IH L}	High-level input voltage, ID0, ID1, EN, BYPASS	1.4		2.625	V
V _{IL SM}	Low-level input voltage, SCL, SDA (2)	-0.15		0.8	V
V _{IH SM}	High-level input voltage, SCL, SDA (2)	1.4		3.465	V

⁽¹⁾ When using a single-ended clock input, V_{th} is supplied to the REFCLKB pin. Duty cycle of single-ended REFCLK input is measured at V_{th}.

⁽²⁾ The input and output negative voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

⁽³⁾ The package thermal impedance is calculated in accordance with JESD 51 and JEDEC2S1P (high-k board).

⁽²⁾ This range of SCL and SDA input high voltage allows the CDCD5704 to co-exist with 3.3 V, 2.5 V, and 1.8 V devices on the same serial-interface bus system.



RECOMMENDED AC OPERATING CONDITIONS

		MIN	NOM MAX	UNIT
t _{CYCLE,IN}	REFCLK/REFCLKB input cycle time	7	11	ns
$t_{CYC,TEST}$	REFCLK/REFCLKB input cycle time for BYPASS	4	40	ns
$t_{J,IN}$	Input cycle-to-cycle jitter(1)		185	ps
DC _{IN}	Input duty cycle over 10,000 cycles (2)	40%	60%	
t _r /t _f	Rise and fall time for REFCLK signal from 20% to 80% of input voltage V_{IN}	175	700	ps
t _{cr} /t _{cf}	Difference between rise time and fall time of REFCLK signal from 20% to 80%		150	ps
f _{m,IN}	SSC frequency modulation repeat frequency ⁽³⁾	30	33	kHz
P _{m tria}	Modulation index (= frequency deviation/center frequency) for triangle modulation (3)		0.6%	
P _{m n tria}	Modulation index (= frequency deviation/center frequency) for non-triangle modulation (4)		0.5%	
t _{SR}	Input slew rate REFCLK/REFCLKB	1	4	V/ns
SERIAL II	NTERFACE TIMING			
f _{SCLK}	SCLK frequency ⁽⁵⁾	0	100	kHz
t _{h(START)}	START hold time ⁽⁵⁾	4		μs
t _{w(SCLL)}	SCLK low-pulse duration ⁽⁵⁾	4.7		μs
t _{w(SCLH)}	SCLK high-pulse duration (5)	4		μs
t _{su(START)}	START setup time ⁽⁵⁾	4.7		μs
t _{h(SDATA)}	SDATA hold time ⁽⁵⁾	300		ps
t _{su(SDATA)}	SDATA setup time ⁽⁵⁾	250		ps
$\underset{r_{(SM)}}{t_{r(SDATA)}}/$	SDATA/SCLK input rise time ⁽⁵⁾		1000	ns
$t_{f(SDATA)}/t_{f(SM)}$	SDATA/SCLK input fall time ⁽⁵⁾		300	ns
t _{su(STOP)}	STOP setup time ⁽⁵⁾	4		μs
t _(BUS)	Bus free time	4.7		μs

- RefCLK jitter is measured at $(V_{IH(nom)} V_{IL(nom)})/2$ and is the absolute value of the worst-case deviation. Measured at crossing points for differential clock input or at input threshold voltage V_{TH} for single-ended clock input. (2)
- If input modulation is used; input modulation is allowed but not required.
- The amount of allowed spreading for any non-triangular modulation is determined by the induced downstream tracking skew, which cannot exceed the skew generated by the specified 0.6% triangular modulation. Typically, the amount of allowed non-triangular modulation is about 0.5%.
- See Figure 1 for the timing behavior of the serial interface.

DEVICE CHARACTERISTICS

over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OVERALL	PARAMETER					
	Supply ourront (- 1 1 1 1 1 1)	At 300 MHz and 2.625 V		70	85	mA
I _{DD}	Supply current (= I_{VDD} + I_{VDDP} + I_{VDDC})	At 667 MHz and 2.625 V		90	115	MA
V _{PUC}	Supply voltage threshold for power-up control circuit	Over complete supply voltage range	1.1	1.8	2.2	V
DC DEVIC	CE CHARACTERISTICS					
V _{OX}	Differential output crossing-point voltage (1)	Output load; see Figure 3.	0.9	1	1.1	V
V _{cos}	Output voltage swing (p-p, single-ended) ⁽²⁾		0.3	0.325	0.35	V
$V_{OL,ABS}$	Absolute output low voltage ⁽³⁾		0.85			V
V _{ISET}	Reference voltage for swing control current IREF ⁽⁴⁾	V _{DD} = 2.375 V to 2.625 V, T = 0°C to 70°C	0.98	1	1.02	V

- (1) V_{OX} is measured on external divider as shown in Figure 3.
- V_{COS} = (clock output high voltage clock output low voltage), at the measurement points shown in Figure 3, excluding overshoot and
- $V_{\text{OL},\text{ABS}}$ is measured at the clock output of the package, instead of the measurement points of Figure 3.
- (4) I_{REF} is equal to V_{ISET}/R_{RC} . Tolerance of R_{RC} must be $\pm 1\%$ or smaller.



DEVICE CHARACTERISTICS (continued)

over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
I _{OL} /I _{REF}	Ratio of output low current to reference current		6.8	7	7.2	
I _{OL,ABS}	Minimum current at V _{OL,ABS} ⁽⁵⁾	V _{OL,ABS} = 0.85 V	45			mA
V _{OL,SDA}	SDA output low voltage	$V_{DD} = 2.375 \text{ V to } 2.625 \text{ V},$ $I_{OH} = 4 \text{ mA}$			0.4	V
I _{OL,SDA}	SDA output low current	$V_{DD} = 2.375 \text{ V to } 2.625 \text{ V},$ $V_{O} = 0.8 \text{ V}$	6			mA
I _{OZ}	Output 3-state current	CLK0 to CLK4			±50	μΑ
I _{IR}	REFCLK input current	$V_I = 0 \text{ V or } V_{DD}$			±5	μΑ
I _{IL}	Logic input current	V _I = 0 V or V _{DD}			±10	μΑ
AC DEVIC	E CHARACTERISTICS					
C _{IR}	Input capacitance, REFCLK, REFCLKB ⁽⁶⁾			2	7	pF
C _{IL}	Input capacitance logic pins ⁽⁷⁾			2	10	pF
t _{CYCLE}	Clock cycle time (8)	300 MHz to 667 MHz, possible SSC is not taken into account	1.5		3.33	ns
	Cycle to expla iitted of 1. C cleak explan	10,000 cycles, 300 MHz to 635 MHz ⁽⁹⁾			40	
t _{jit(per)}	Cycle-to-cycle jitter of 1–6 clock cycles	10,000 cycles, 636 MHz to 667 MHz ⁽⁹⁾			30	ps
L ₁	SSB phase noise at 1 MHz	300-MHz-667-MHz output (10)		-115	-97	dBc/Hz
L ₂₀	SSB phase noise at 20 MHz	300-MHz-667-MHz output ⁽¹⁰⁾		-150	-128	dBc/Hz
$\Delta t_{\text{skew(o)}}$	Drift in t _{skew(o)} ⁽¹¹⁾	V _{DD} = 2.375 V to 2.625 V, T = 0 to 70°C			15	ps
odc	Output duty cycle		45%	50%	55%	
	10 cele to cordel data corde	300 MHz to 635 MHz			40	
t _{ODC,ERR}	Cycle-to-cycle duty-cycle error	636 MHz to 667 MHz			30	ps
t _{ERR,SSC}	PLL output phase error when tracking SSC		-100		100	ps
t _r /t _f	Output rise and fall time	V _{OUT} = 20%–80%	100		300	ps
t _{cr} /t _{cf}	Difference between output rise and fall times	V _{OUT} = 20%–80%, f _{out} = 300 MHz to 667 MHz			100	ps
Z _{OUT}	Output dynamic impedance ⁽¹²⁾	V _{OL} = 0.9 V	750			Ω
tL	Power-up lock time	Time from VDD, VDDP, VDDC being applied and settled until clock outputs are settled			3	ms
$t_{L(\omega)}$	PLL lock time after (1) frequency change via serial interface (programming of SCL and SDA pins completed) or (2) EN and/or BYPASS changed state	Time from signals for selecting a mode of operation (1) or (2) applied and settled until clock outputs are settled			3	ms

- Minimum I_{OLABS} is measured at the clock output pins of the package, as shown in Figure 3.
- Capacitance measured at frequency = 1 MHz, dc bias = 0.9 V, and $V_{AC} < 100 \text{ mV}$ Capacitance measured at frequency = 1 MHz, dc bias = 0.9 V, and $V_{AC} < 100 \text{ mV}$ (6)
- (7)
- Maximum and minimum output clock cycle times are based on nominal output frequency of 300 MHz and 667 MHz, respectively. For spread-spectrum-modulated differential or single-ended REFCLK, the output clock tracks the modulation of the input.
- Output short-term jitter specification is the absolute value of the worst-case deviation and is defined in the Jitter section.
- (10) Device must not exceed the upper limit of L(f) for 1-MHz to 100-MHz offset as shown in the Phase Noise section.
- (11) t_{skew} is the timing difference between any two of the four differential clocks and is measured at common-mode voltage. Δt_{skew} is the change in t_{skew} when the operating temperature and supply voltage change.
- (12) Z_{OUT} is defined at the output pins directly. The value is determined as the ac small-signal impedance at low frequencies (< 100 kHz) and when output is driving a high state.



PHASE NOISE

For the offset frequency range from 1 MHz to 100 MHz, phase noise of the CDCD5704 does not exceed the single-sideband phase noise (spectral purity) described by the following equation given by Rambus.

$$L(f) = 10 log [1 + (50 \times 10^6 / f)^{2.4}] - 138 dBc/Hz$$

Selected numerical values are in given in the following table.

f = offset frequency	1 (L ₁)	5	10	15	20 (L ₂₀)	40	80	100	MHz
L(f) = SSB phase noise	-97	-114	-121	-125	-128	-134	-137	-138	dBc/Hz

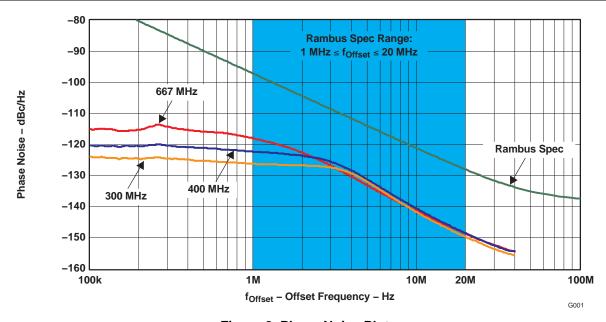
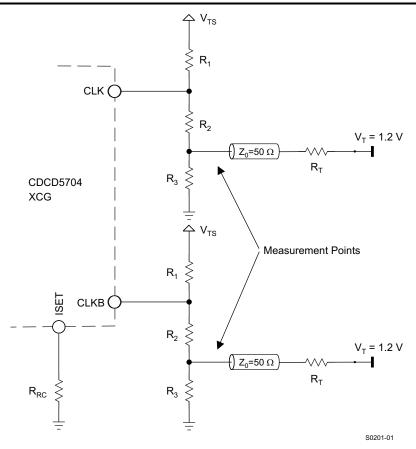


Figure 2. Phase Noise Plot





NOTE: In the power-up sequence, the rise time for the external voltage applied to the clock output pins (V_{TS}) must be equal to or longer than the rise time for the supply voltage of the device $(V_{DD},\,V_{DDP},\,V_{DDC})$.

PARAMETER		VALUE for 50- Ω LINE	VALUE for I _{OL,ABS}	TOLERANCE	UNIT
R ₁	Termination resistor	39.2	34	±1%	Ω
R ₂	Termination resistor	66.5	31.8	±1%	Ω
R_3	Termination resistor	93.1	48.7	±1%	Ω
R _T	Termination resistor	49.9	28	±1%	Ω
R _{RC}	Swing control resistor	200	147	±1%	Ω
V_{TS}	Source termination voltage	2.5	2.5	±5%	V
V _T	Termination voltage	1.2	1.2	±5%	V

Figure 3. Output Test Load

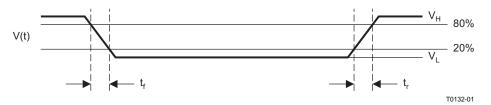


Figure 4. Input and Output Waveforms

T0135-01



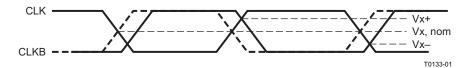


Figure 5. Crossing-Point Voltage

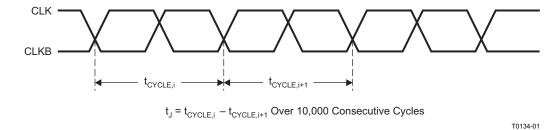


Figure 6. One-Period Cycle-to-Cycle Jitter

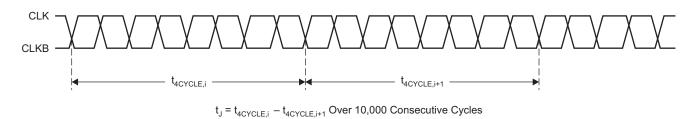


Figure 7. Four-Period Cycle-to-Cycle Jitter

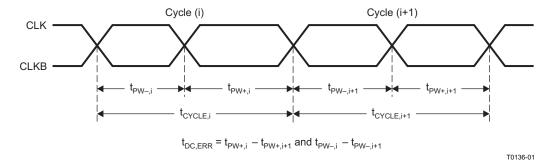
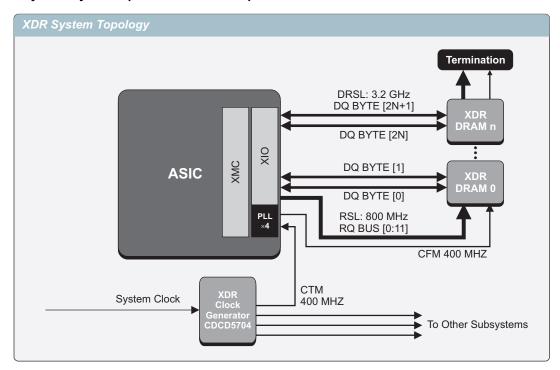


Figure 8. Cycle-to-Cycle Duty-Cycle Error



APPLICATION INFORMATION

XDR Memory Subsystem (Source: Rambus)



M0054-01





ii.com 24-Jan-2013

PACKAGING INFORMATION

Orderable Device	Status	Package Type	_	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
	(1)		Drawing			(2)		(3)		(4)	
CDCD5704PW	ACTIVE	TSSOP	PW	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	CDCD5704.	Samples
CDCD5704PWG4	ACTIVE	TSSOP	PW	28	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	CDCD5704.	Samples
CDCD5704PWR	ACTIVE	TSSOP	PW	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	CDCD5704.	Samples
CDCD5704PWRG4	ACTIVE	TSSOP	PW	28	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 70	CDCD5704.	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ Only one of markings shown within the brackets will appear on the physical device.

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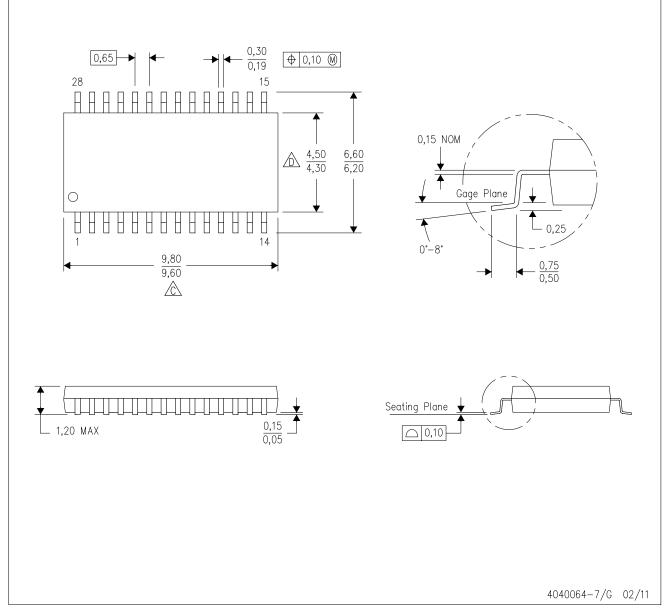




24-Jan-2013

PW (R-PDSO-G28)

PLASTIC SMALL OUTLINE



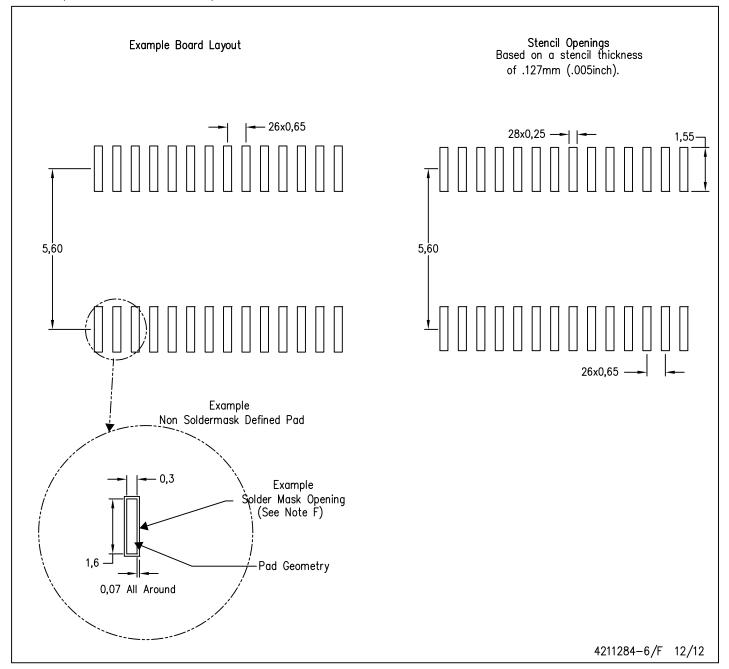
NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



PW (R-PDSO-G28)

PLASTIC SMALL OUTLINE



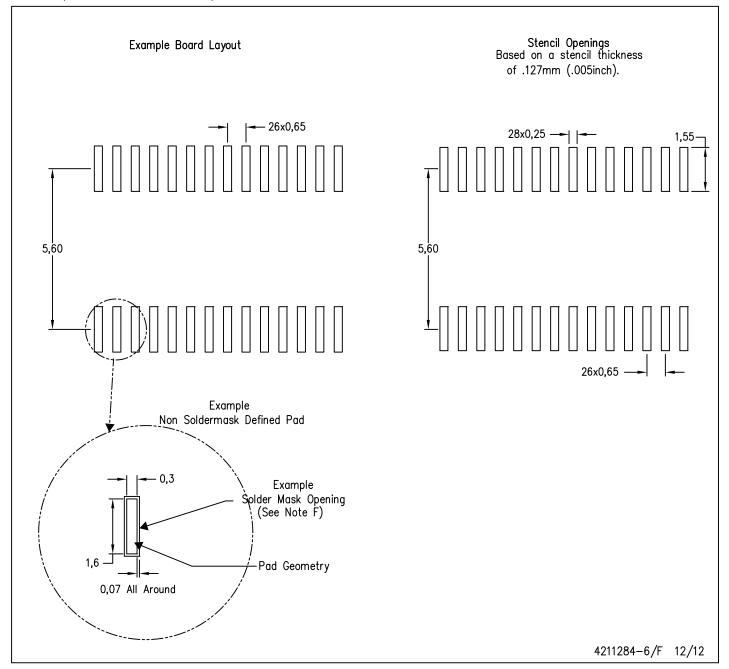
NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G28)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate design.
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- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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